

32K x 8 LOW POWER CMOS STATIC RAM

PRELIMINARY INFORMATION SEPTEMBER 2002

FEATURES

• High-speed access time: 20 ns

• Low active power: 200 mW (typical)

Low standby power:
 250 µW (typical) CMOS standby

Fully static operation: no clock or refresh required

• TTL compatible inputs and outputs

• Single 5V power supply

· Temperature Offerings:

Option A1: -40°C to +85°C Option A2: -40°C to +105°C Option A3: -40°C to +125°C

DESCRIPTION

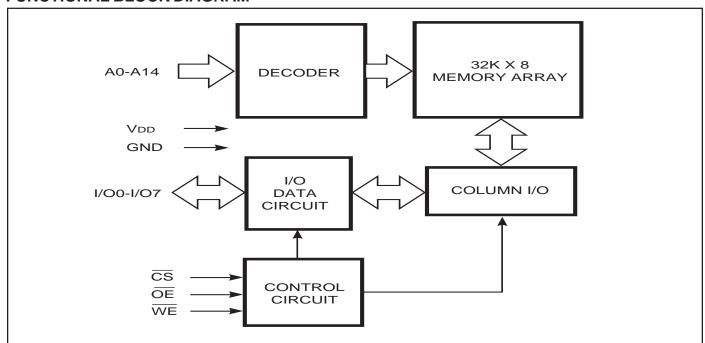
The ISSI IS65C256 is a low power, 32,768 word by 8-bit CMOS static RAM. It is fabricated using ISSI's high-performance, low power CMOS technology.

When CS is HIGH (deselected), the device assumes a standby mode at which the power dissipation can be reduced down to 250 μ W (typical) at CMOS input levels.

Easy memory expansion is provided by using an active LOW Chip Select (CS) input and an active LOW Output Enable (OE) input. The active LOW Write Enable (WE) controls both writing and reading of the memory.

The IS65C256 is Packaged in the JEDEC Standard 28-Pin SOP and 28-Pin TSOP (Type I).

FUNCTIONAL BLOCK DIAGRAM

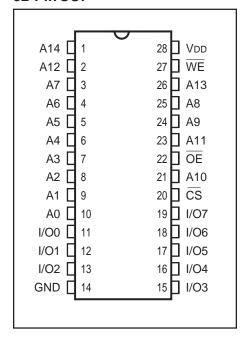


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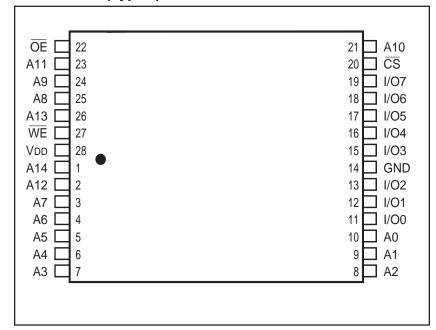
PIN CONFIGURATION

32-Pin SOP



PIN CONFIGURATION

32-Pin TSOP (Type 1)



PIN DESCRIPTIONS

A0-A14	Address Inputs
CS	Chip Select Input
ŌE	Output Enable Input
WE	Write Enable Input
I/O0-I/O7	Input/Output
VDD	Power
GND	Ground

TRUTH TABLE

Mode	WE	<u>CS</u>	ŌĒ	I/O Operation	VDD Current
Not Selected (Power-down)	Х	Н	Χ	High-Z	ISB1, ISB2
Output Disabled	I H	L	Н	High-Z	Icc1, Icc2
Read	Н	L	L	D оит	Icc1, Icc2
Write	L	L	Χ	DIN	Icc1, Icc2

ABSOLUTE MAXIMUM RATINGS(1)

Symbol	Parameter	Value	Unit	
VTERM	Terminal Voltage with Respect to GND	-0.5 to +7.0	V	
TBIAS	Temperature Under Bias	-55 to +125	°C	
Тѕтѕ	Storage Temperature	-65 to +150	°C	
Рт	Power Dissipation	0.5	W	
Іоит	DC Output Current (LOW)	20	mA	

^{1.} Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.



OPERATING RANGE

Range	Ambient Temperature	V _{DD}
A1	-40°C to +85°C	5V ± 10%
A2	–40°C to +105°C	5V ± 10%
A3	-40°C to +125°C	5V ± 10%

DC ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Test Conditions		Min.	Max.	Unit
Voh	Output HIGH Voltage	$V_{DD} = Min., I_{OH} = -1.0 \text{ mA}$		2.4	_	V
Vol	Output LOW Voltage	VDD = Min., IOL = 2.1 mA		_	0.4	V
VIH	Input HIGH Voltage			2.2	VDD + 0.5	V
VIL	Input LOW Voltage(1)			-0.3	0.8	V
ILI	Input Leakage	GND - VIN - VDD	Com.	-2	2	μA
			Ind.	-10	10	
ILO	Output Leakage	GND - Vout - Vdd,	Com.	-2	2	μA
		Outputs Disabled	Ind.	-10	10	

Note:

POWER SUPPLY CHARACTERISTICS(1) (Over Operating Range)

					-20 ns			
Symbol	Parameter	Test Conditions		Min.	typ ⁽²⁾	Max.	Unit	
lcc1	Vdd Operating	$V_{DD} = Max., \overline{CS} = V_{IL}$	A1	_		40	mA	
	Supply Current	IOUT = 0 mA, f = 0	A2	_		50		
			A3	_		60		
Icc2	Vdd Dynamic Operating	$V_{DD} = Max., \overline{CS} = V_{IL}$	A1	_	25	95	mA	
	Supply Current	IOUT = 0 mA, f = fMAX	A2	_	25	105		
			А3	_	25	115		
IsB1	TTL Standby Current	VDD = Max.,	A1	_		5	mA	
	(TTL Inputs)	VIN = VIH or VIL	A2	_		10		
		$\overline{CS} = V_{IH}, f = 0$	A3	_		10		
IsB2	CMOS Standby	VDD = Max.,	A1	_		0.5	mA	
	Current (CMOS Inputs)	$\overline{CS} = VDD - 0.2V$,	A2	_		1.0		
		$V_{IN} = V_{DD} - 0.2V$, or	A3	_		1.5		
		$Vin \le 0.2V, f = 0$						

^{1.} $V_{IL} = -3.0V$ for pulse width less than 10 ns.

^{1.} At f = fmax, address and data inputs are cycling at the maximum frequency, f = 0 means no input lines change. 2. Typical values are measured at VDD = 5V, TA = 25°C, tAA = 70 ns, and not 100% tested.



CAPACITANCE(1,2)

Symbol	Parameter	Conditions	Max.	Unit	
CIN	Input Capacitance	VIN = 0V	8	pF	
Соит	Output Capacitance	Vout = 0V	10	pF	

Notes:

- 1. Tested initially and after any design or process changes that may affect these parameters.
- 2. Test conditions: $TA = 25^{\circ}C$, f = 1 MHz, VDD = 5.0V.

DATA RETENTION CHARACTERISTICS

Symbol	Parameter	Test Conditions	Options	Min.	typ (1)	Max.	Units
V DR	VDD for retention of data			2.0		_	V
IDR1	Data retention current	VDR = 3.0V	A1	_	50	150	μA
DR2	Data retention current	VDR = 3.0V	A2	_	50	300	μA
IDR3	Data retention current	VDR = 3.0V	А3	_	50	500	μΑ

Note:

2. Typical values are measured at VDD = 3V, TA = 25°C, and not 100% tested.

READ CYCLE SWITCHING CHARACTERISTICS(1) (Over Operating Range)

		-20	ns	
Symbol	Parameter	Min.	Max.	Unit
t rc	Read Cycle Time	20	_	ns
taa	Address Access Time	_	20	ns
t oha	Output Hold Time	3	_	ns
tacs	CS Access Time	_	20	ns
t DOE	OE Access Time	_	8	ns
tLZOE ⁽²⁾	OE to Low-Z Output	0	_	ns
thzoe(2)	OE to High-Z Output	0	9	ns
tLZCS(2)	CS to Low-Z Output	3	_	ns
thzcs(2)	CS to High-Z Output	0	9	ns
t PU ⁽³⁾	CS to Power-Up	0	_	ns
t PD ⁽³⁾	CS to Power-Down	_	18	ns

- 1. Test conditions assume signal transition times of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V and output loading specified in Figure 1.
- 2. Tested with the load in Figure 2. Transition is measured ±500 mV from steady-state voltage. Not 100% tested.
- 3. Not 100% tested.



AC TEST CONDITIONS

Parameter	Unit
Input Pulse Level	0V to 3.0V
Input Rise and Fall Times	3 ns
Input and Output Timing and Reference Levels	1.5V
Output Load	See Figures 1 and 2

AC TEST LOADS

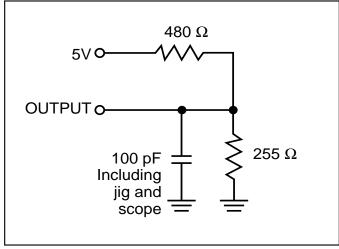


Figure 1.

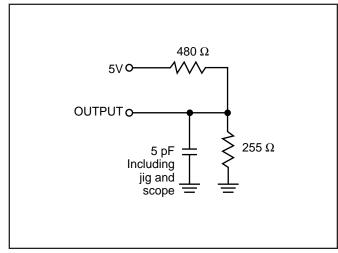
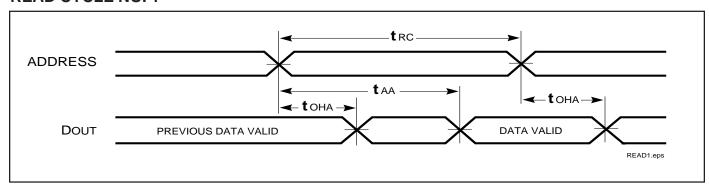


Figure 2.

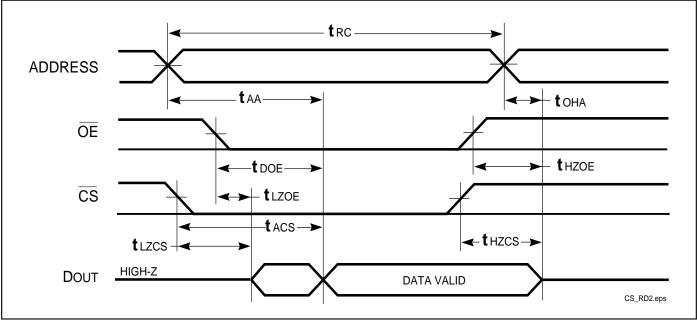
AC WAVEFORMS

READ CYCLE NO. 1^(1,2)





READ CYCLE NO. 2(1,3)



Notes:

- 1. WE is HIGH for a Read Cycle.
- 2. The device is continuously selected. \overline{OE} , $\overline{CS} = V_{IL}$.
- 3. Address is valid prior to or coincident with \overline{CS} LOW transitions.

WRITE CYCLE SWITCHING CHARACTERISTICS^(1,3) (Over Operating Range)

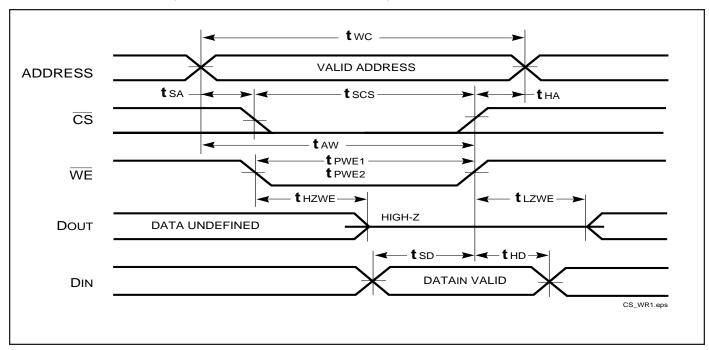
	-20 ns						
Symbol	Parameter	Min.	Max.	Unit			
twc	Write Cycle Time	20	_	ns			
tscs	CS to Write End	13	_	ns			
taw	Address Setup Time to Write End	15	_	ns			
t ha	Address Hold from Write End	1	_	ns			
t sa	Address Setup Time	0	_	ns			
tpwe ⁽⁴⁾	WE Pulse Width	13	_	ns			
t sp	Data Setup to Write End	10	_	ns			
t HD	Data Hold from Write End	0	_	ns			

- 1. Test conditions assume signal transition times of 5 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V and output loading specified in Figure 1.
- 2. Tested with the load in Figure 2. Transition is measured ±500 mV from steady-state voltage. Not 100% tested.
- 3. The internal write time is defined by the overlap of CS LOW and WE LOW. All signals must be in valid states to initiate a Write, but any one can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the write.
- 4. Tested with OE HIGH.

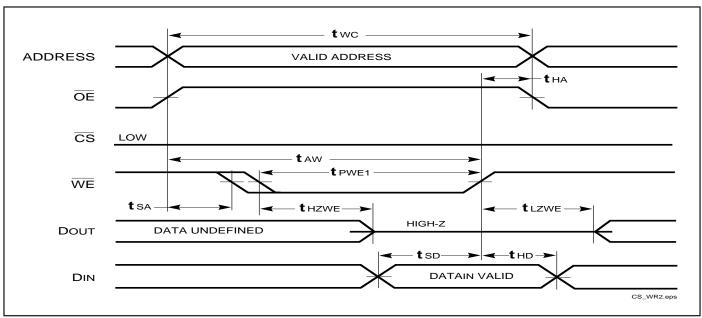


AC WAVEFORMS

WRITE CYCLE NO. 1 (CS Controlled, OE is HIGH or LOW) (1)



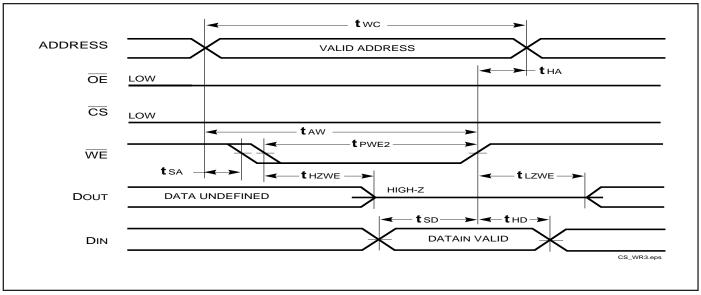
WRITE CYCLE NO. 2 (OE is HIGH During Write Cycle) (1,2)



- 1. The internal write time is defined by the overlap of CE1 LOW, CE2 HIGH and WE LOW. All signals must be in valid states to initiate a Write, but any one can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the Write.
- 2. I/O will assume the High-Z state if $\overline{OE} = V_{IH}$.



WRITE CYCLE NO. 3 (OE is LOW During Write Cycle) (1)

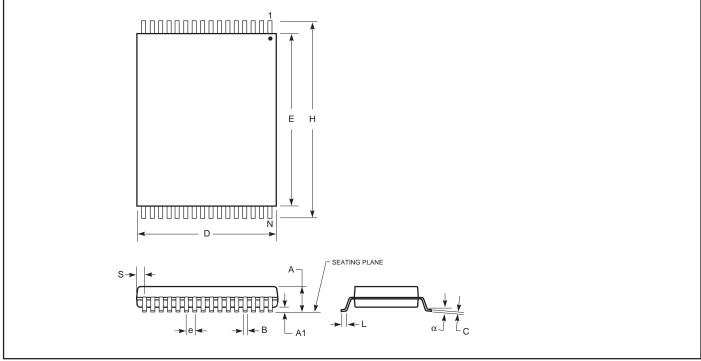


- 1. The internal write time is defined by the overlap of $\overline{\text{Cs}}$ LOW and $\overline{\text{WE}}$ LOW. All signals must be in valid states to initiate a Write, but any one can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the write.
- 2. I/O will assume the High-Z state if $\overline{OE} = V_{IH}$.



Plastic TSOP

Package Code: T (type I)



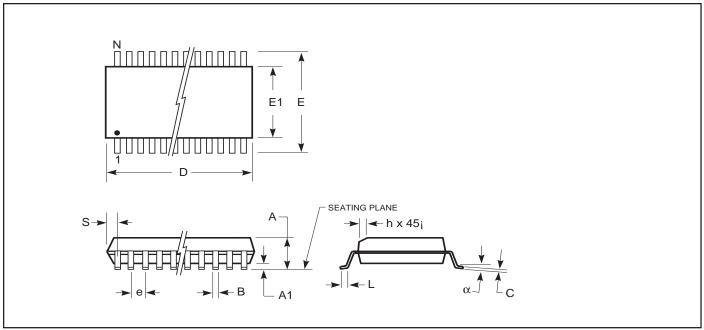
- Controlling dimension: millimeters, unless otherwise specified.
 BSC = Basic lead spacing between centers.
- Dimensions D and E1 do not include mold flash protrusions and should be measured from the bottom of the package.
 Formed leads shall be planar with respect to one another within 0.004 inches at the seating plane.

	Plastic	rsop (T -	Type I)		
	Millime	eters		Inch	es
Symbol	Min	Max		Min	Max
Ref. Std.					
No. Leads (N)			28		
А	1.00	1.20		0.037	0.047
A1	0.050	0.20		0.002	0.008
В	0.16	0.27		0.006	0.011
С	0.10	0.20		0.004	0.008
D	7.90	8.10		0.308	0.318
E1	11.70	10.29		0.395	0.405
Е	11.56	11.90		0.456	0.465
Н	13.20	13.60		0.515	0.531
е	0.55	BSC		0.022	2 BSC
L	0.30	0.70		0.011	0.027
α	0°	5°		0°	5°



330-mil Plastic SOP

Package Code: U



- 1. Controlling dimension: millimeters, unless otherwise specified.
- 2. BSC = Basic lead spacing between centers.
- 3. Dimensions D and E1 do not include mold flash protrusions and should be measured from the bottom of the package.
- 4. Formed leads shall be planar with respect to one another within 0.004 inches at the seating plane.

330-mil Plastic SOP (U)					
Inches					
Symbol	Min	Max			
Ref. Std.					
No. Leads (N)	2	8			
A	_	0.112			
A1	0.004	_			
В	0.014	0.020			
С	0.010	_			
D	0.708	0.718			
Е	0.453	0.477			
E1	0.326	0.336			
е	0.75 BSC				
h	0.012	0.020			
L	0.028	0.045			
α	0°	8°			
S	0.023	0.047			



ORDERING INFORMATION

Temperature Range (A1): -40°C to +85°C

Speed(ns)	Order Part No.	Package	
20	IS65C256-20TA1	TSOP	
	IS65C256-20UA1	PlasticSOP	

Temperature Range (A2): -40°C to +105°C

Speed (ns)	Order Part No.	Package	
20	IS65C256-20TA2	TSOP	
	IS65C256-20UA2	Plastic SOP	

Temperature Range (A3): -40°C to +125°C

Speed(ns)	Order Part No.	Package	
20	IS65C256-20TA3	TSOP	
	IS65C256-20UA3	PlasticSOP	